

MOSFET - Power, Single N-Channel

80 V, 6.7 mΩ, 80 A

NVMFS6H836N

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6H836NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halide Free, and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	80	V
Gate-to-Source Voltage	€		V_{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	74	Α
Current R _{0JC} (Notes 1, 3)	State	T _C = 100°C		53	
Power Dissipation		T _C = 25°C	P _D	89	W
R _{θJC} (Note 1)		T _C = 100°C		44	
Continuous Drain	Steady State $T_A = 25^{\circ}C$ $T_A = 100^{\circ}C$		I _D	15	Α
Current R _{0JA} (Notes 1, 2, 3)				11	
Power Dissipation	T _A = 25°C		P_{D}	3.7	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \mu s$		I _{DM}	432	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			IS	74	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 4.6 A)			E _{AS}	521	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

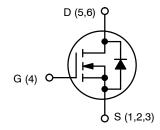
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40.6	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface–mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	6.7 m Ω @ 10 V	80 A



N-CHANNEL MOSFET

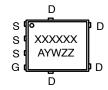






DFNW5 5x6 (FULL-CUT SO8FL WF) CASE 507BA

MARKING DIAGRAM



XXXXXX = 6H836N

(NVMFS6H836N) or

836NWF

(NVMFS6H836NWF) = Assembly Location

Y = Year

W = Work Week

ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu$	A	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				39		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		V _{DS} = 80 V	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V	V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = 95 \mu$	A	2.0		4.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-7.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 15 A		5.6	6.7	mΩ
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I _D = 25 A	•		97		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE				•	•	•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 40 V			1640		pF
Output Capacitance	C _{OSS}				230		1
Reverse Transfer Capacitance	C _{RSS}				8.0		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 25 A			25		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 25 A			5.2		1
Gate-to-Source Charge	Q _{GS}				8.5		1
Gate-to-Drain Charge	Q_{GD}				4.3		1
Plateau Voltage	V_{GP}				4.9		V
SWITCHING CHARACTERISTICS (Note	5)				•	•	•
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 10 V, V _{DS} = 64	V,		16		ns
Rise Time	t _r	$I_D = 25 \text{ A}, R_G = 2.5 \Omega$	}		45		1
Turn-Off Delay Time	t _{d(OFF)}				41		
Fall Time	t _f	1			34		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS	•			•		•
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 15 A	T _J = 25°C		0.8	1.2	V
			T _J = 125°C		0.7		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, \text{ dIS/dt} = 10$	00 A/μs,		43		ns
Charge Time	ta	I _S = 25 A			29		1
Discharge Time	t _b				15		1
Reverse Recovery Charge	Q _{RR}				54		nC

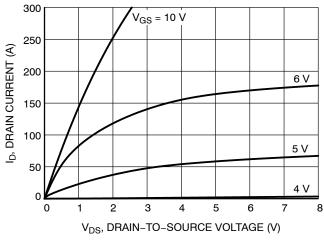
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300 \ \mu s$, duty cycle $\leq 2\%$.

^{5.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

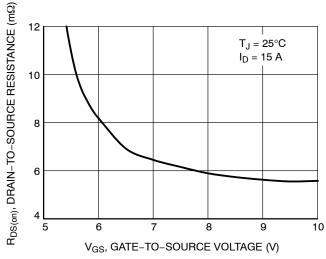
300



250 T_J = 25°C ID, DRAIN CURRENT (A) 200 150 100 50 = −55°C 0 0 5 6 7 2 8 10 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



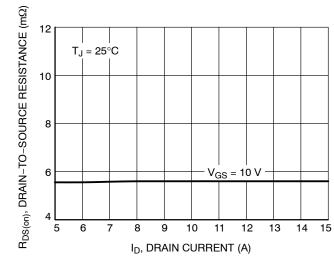
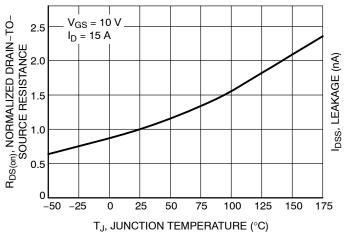


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



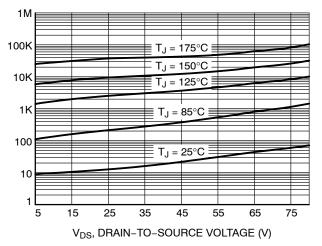


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (continued)

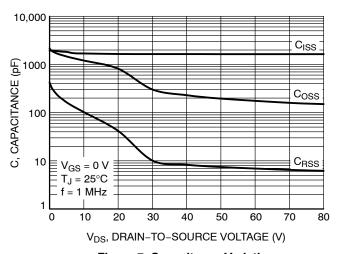


Figure 7. Capacitance Variation

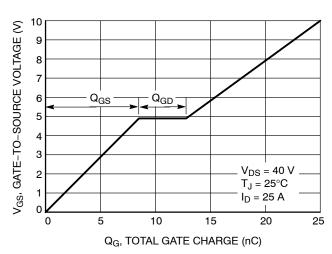


Figure 8. Gate-to-Source Voltage vs. Total Charge

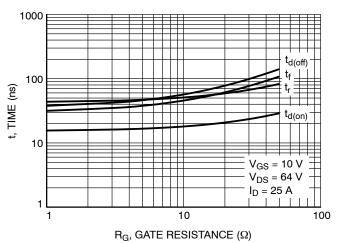


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

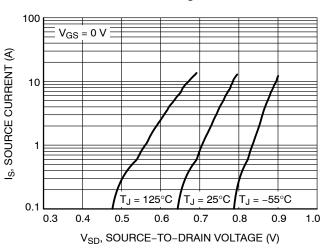


Figure 10. Diode Forward Voltage vs. Current

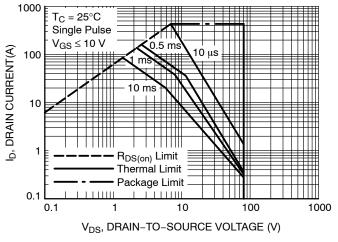


Figure 11. Maximum Rated Forward Biased Safe Operating Area

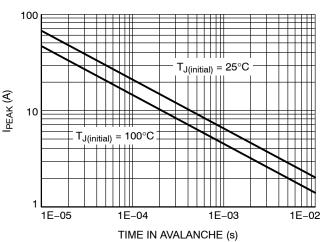


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS (continued)

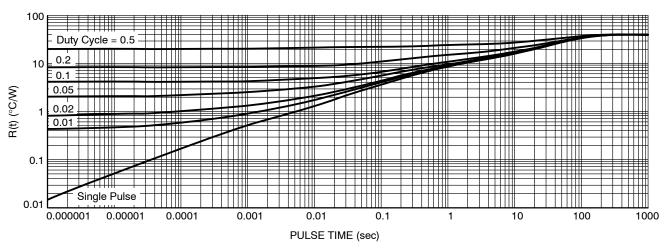


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS6H836NT1G	6H836N	DFN5 (Pb-Free, Halide Free)	1500 / Tape & Reel
NVMFS6H836NT3G	6H836N	DFN5 (Pb-Free, Halide Free)	5000 / Tape & Reel
NVMFS6H836NWFT1G	836NWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS6H836NWFT3G	836NWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е		1.27 BSC	;	
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
М	3.00	3.40	3.80	
θ	0 °		12 °	

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

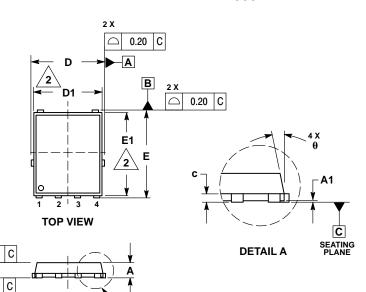
= Assembly Location Α

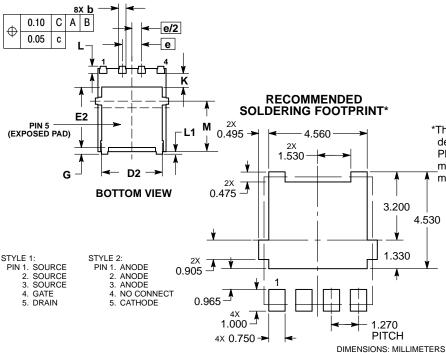
= Lot Traceability

Υ = Year W = Work Week

ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1

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PIN 1

IDENTIFIER

// 0.10 C

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DFNW5 5x6 (FULL-CUT SO8FL WF)

CASE 507BA **ISSUE A**

DATE 03 FEB 2021

MILLIMETERS



TES:

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.

CONTROLLING DIMENSION: MILLIMETERS

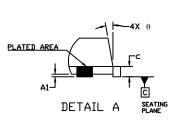
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,

PROTRUSIONS, OR GATE BURRS.

THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN

FEATURES TO AID IN FILLET FORMATION ON THE LEADS

DURING MOUNTING.

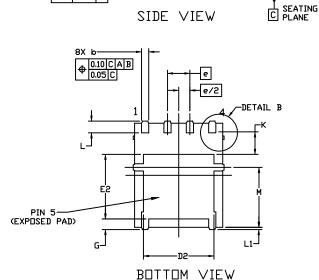


DIM	MIN.	N□M.	MAX.
Α	0.90	1.00	1.10
A1	0.00		0.05
b	0.33	0.41	0.51
C	0.23	0.28	0.33
D	5.00	5.15	5.30
D1	4.70	4.90	5.10
D2	3.80	4.00	4.20
Ε	6.00	6.15	6.30
E1	5.70	5.90	6.10
E2	3.45	3.65	3.85
e		1.27 BSC	
G	0.51	0.575	0.71
K	1.20	1.35	1.50
L	0.51	0.575	0.71
L1	0.150 REF		

3.40

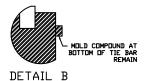
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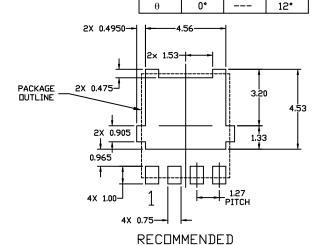
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TOP VIEW

DETAIL A





М

GENERIC MARKING DIAGRAM*



= Assembly Location Α Υ = Year

W = Work Week 77 = Lot Traceability

XXXXXX = Specific Device Code *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

MOUNTING FOOTPRINT For additional information on our Pb-Free strategy and soldering details, please download the $\square N$

Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

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DESCRIPTION:	DFNW5 5x6 (FULL-CUT Se	08FL WF)	PAGE 1 OF 1

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